## CDC9843 PC MOTHERBOARD CLOCK SYNTHESIZER/DRIVER WITH 3-STATE OUTPUTS

SCAS559C - DECEMBER 1995 - REVISED OCTOBER 1996

- **Provides System Clock Solution for** Pentium™/82430HX/82430VX and Pentium Pro 82440FX Chipsets
- **Four Host-Clock Outputs With Programmable Frequency** (50 MHz, 60 MHz, and 66 MHz)
- Six PCI Clock Outputs at Half-CPU Frequency
- One 48-MHz Universal Serial Bus (USB) **Clock Output**
- One 24-MHz Floppy Controller Output
- Two 14.318-MHz Reference Clock Outputs
- **All Output Clock Frequencies Derived From** Single 14.31818-MHz Crystal Input
- **LVTTL-Compatible Inputs and Outputs**
- **Internal Loop Filters for Phase-Lock Loops** Eliminate the Need for External Components
- Operates at 3.3-V V<sub>CC</sub>
- Packaged in Plastic Small-Outline Package

#### (TOP VIEW) 28 REF0 $V_{CC}$ X1 🛮 2 27 REF1 26 V<sub>CC</sub> X2 **∏** 3 25 SBCLK GND ∏ 4 OΕ [] 5 24 TFCCLK HCLK0 6 23 GND HCLK1 **∏** 7 22 PCLK0 V<sub>CC</sub> **[**] 8 21 T PCLK1 HCLK2 9 20 V<sub>CC</sub> HCLK3 10 19 PCLK2 GND **1** 11 18 PCLK3 17 ¶ GND SEL0 [] 13 16 PCLK4 15 PCLK5 $V_{CC}I$

**DW PACKAGE** 

#### description

The CDC9843 is a high-performance clock synthesizer/driver that generates the system clocks necessary to support Pentium™/82430HX/82430VX and Pentium Pro 82440FX chipsets. Four host-clock outputs (HCLKn) are programmable to one of three frequencies (50 MHz, 60 MHz, or 66 MHz) via the SEL0 and SEL1 control inputs. Six PCI-clock outputs (PCLKn) are half the frequency of CPU clock outputs and are delayed 1 ns to 4 ns from the rising edge of the CPU clock. In addition, a universal serial bus (USB) clock output at 48 MHz (SBCLK), a floppy controller clock at 24 MHz (FCCLK), and two 14.318-MHz reference clock outputs (REF0, REF1) are provided.

All output frequencies are generated from a 14.318-MHZ crystal input. A reference clock input can be provided at the X1 input instead of a crystal input.

Two phase-locked loops (PLLs) are used to generate the host clock frequency and the 48-MHz clock frequency. On-chip loop filters and internal feedback eliminate the need for external components. The PCI-clock frequency and floppy controller frequency are derived directly from the host-clock frequency and USB frequency, respectively. The PLL circuit can be bypassed in the test mode (i.e., SEL0 = SEL1 = H) to distribute a test clock provided at the X1 input.

The host- and PCI-clock outputs provide low-skew/low-jitter clock signals for reliable clock operation. All outputs are 3 state and are enabled via OE.

Because the CDC9843 is based on PLL circuitry, it requires a stabilization time to achieve phase-lock of the PLL. This stabilization time is required following power up and application of a fixed-frequency, fixed-phase signal at the X1, as well as following any changes to the OE or SELn inputs.



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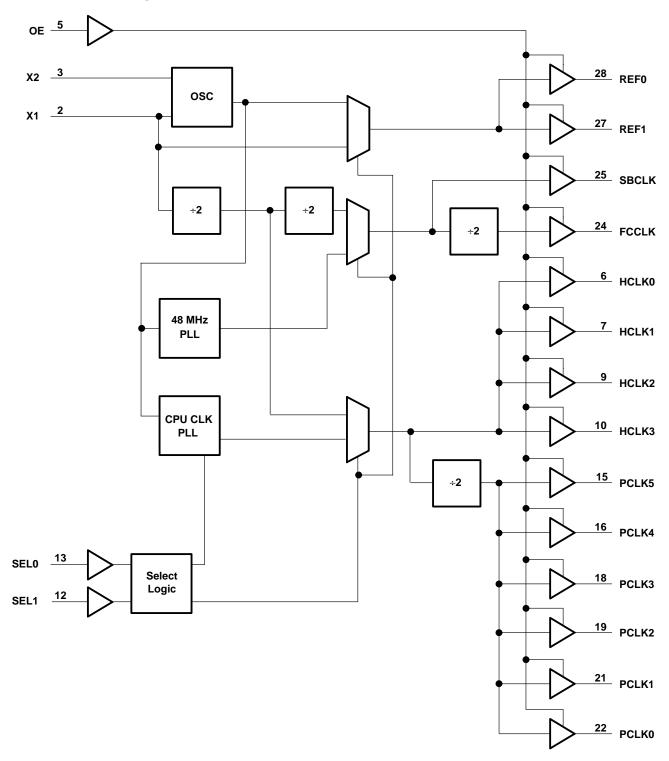
#### **FUNCTION TABLE**

OE	SEL0	SEL1	X1	HCLKn	PCLKn	REFn	SBCLK	FCCLK
L	Х	Х	14.318 MHz	Hi-Z	Hi-Z	Hi-Z	Hi-Z	Hi-Z
Н	L	L	14.318 MHz	50 MHz	25 MHz	14.318 MHz	48 MHz	24 MHz
Н	L	Н	14.318 MHz	60 MHz	30 MHz	14.318 MHz	48 MHz	24 MHz
Н	Н	L	14.318 MHz	66 MHz	33 MHz	14.318 MHz	48 MHz	24 MHz
Н	Н	Н	TCLK <sup>†</sup>	TCLK/2	TCLK/4	TCLK	TCLK/4	TCLK/8

<sup>†</sup> TCLK is a test-clock input at the X1 input during test mode.



### functional block diagram





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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V<sub>CC</sub> ..... –0.5 V to 4.6 V Input voltage range, V<sub>I</sub> (see Note 1) .....-0.5 V to 4.6 V Voltage range applied to any output in the high-impedance state or power-off state, Input clamp current, I<sub>IK</sub> (V<sub>I</sub> < 0) ......–18 mA 

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

#### recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	3.135	3.6	V
VIH	High-level input voltage	2		V
V <sub>IL</sub>	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
ЮН	High-level output current		-8	mA
l <sub>OL</sub>	Low-level output current		8	mA
T <sub>A</sub>	Operating free-air temperature	0	70	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP‡	MAX	UNIT
$v_{IK}$	$V_{CC} = 3.135 \text{ V},$	I <sub>I</sub> = -18 mA				-1.2	V
Voн	$V_{CC} = 3.135 \text{ V},$	$I_{OH} = -8 \text{ mA}$		2.5			V
$v_{OL}$	V <sub>CC</sub> = 3.135 V,	$I_{OL} = 8 \text{ mA}$				0.4	V
lį	V <sub>CC</sub> = 3.6 V,	$V_I = V_{CC}$ or GND				±1	μΑ
loz	V <sub>CC</sub> = 3.6 V,	$V_O = V_{CC}$ or GND				±10	μΑ
loo	V <sub>CC</sub> = 3.6 V,	I <sub>O</sub> = 0,	Outputs enabled§			50	mA
Icc	$V_I = V_{CC}$ or GND		Outputs disabled			1	mA
C <sub>i</sub>	$V_I = V_{CC}$ or GND				6		pF
Co	$V_I = V_{CC}$ or GND				6		pF

<sup>‡</sup> All typical values are at V<sub>CC</sub> = 3.3 V.



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>2.</sup> The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the Package Thermal Considerations application note in the ABT Advanced BiCMOS Technology Data Book, literature number SCBD002.

<sup>§</sup> Device in normal operating mode with no load on outputs

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# timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN MAX	UNIT
Stabilization time <sup>†</sup>	After SEL1, SEL0	5	
	After OE↑	5	ms
	After power up	5	1

Time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. In order for phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at X1. Until phase lock is obtained, the specifications for propagation delay and skew parameters given in the switching characteristics table are not applicable.

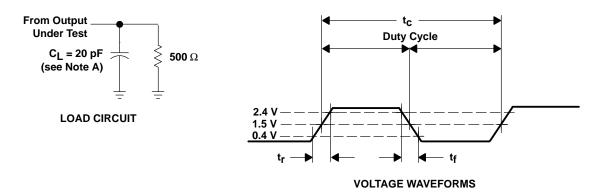
### switching characteristics (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		V <sub>CC</sub> = 3.135 V to 3.6 V, T <sub>A</sub> = 0°C to 70°C		UNIT
				MIN	MAX	
. +			HCLKn		200	ps
t <sub>Skew</sub> ‡		PCLKn			400	ps
Offset <sup>‡</sup>	HCLKn		1	4	ns	
Pro aut		HCKLn PCKLn			±250	ps
Jitter‡					±350	ps
Duty cycle‡		Any output		45%	55%	
			SEL0 = L, SEL1 = L	20		ns
		HCKLn	SEL0 = L, SEL1 = H	16.7		ns
. +			SEL0 = H, SEL1 = L	15		ns
t <sub>c</sub> ‡			SEL0 = L, SEL1 = L	40		ns
		PCLKn	SEL0 = L, SEL1 = H	33.3		ns
			SEL0 = H, SEL1 = L	30		ns
. +8		HCLKn PCKLn			2	
t <sub>r</sub> ‡§				<u> </u>		ns
. +8		HCKLn			2	
t <sub>f</sub> ‡§			PCLKn			ns

<sup>‡</sup> Specifications are applicable only after the PLL stabilization time has elapsed.

<sup>§</sup> Rise and fall times are characterized using the load circuits shown in Figure 1.

## PARAMETER MEASUREMENT INFORMATION CLOCK DRIVER CIRCUITS



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

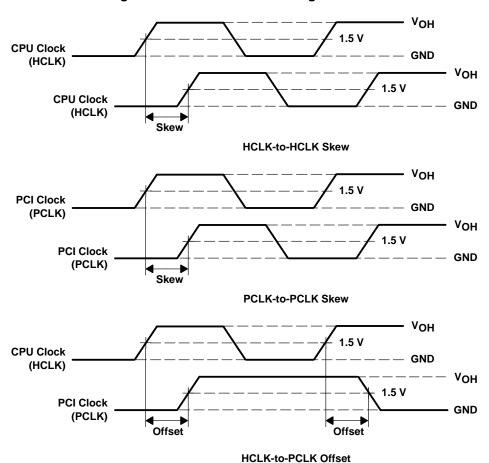


Figure 2. Waveforms for Calculation of t<sub>Skew</sub> and t<sub>offset</sub>



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